

Photograph No.1 Setup for spurious emission field strength measurements in the anechoic chamber below 30 MHz



Photograph No.2 Setup for carrier field strength, spurious emission field strength measurements in the anechoic chamber in 30 – 1000 MHz range



Photograph No.3 Setup for spurious emission field strength measurements in the anechoic chamber above 1000 MHz range



Photograph No.4 Setup for spurious emission field strength measurements in the anechoic chamber, EUT close view



Photograph No.5 Setup for OBW measurements



Photograph No.6 Setup for band edge emissions and hopping parameters measurements





Photograph No.7 Setup for conducted emission measurements on the AC power lines



Photograph No.8 Setup for conducted emission measurements on the AC power lines